

Search Notes 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/527,062	FURUISHI ET AL.	
				Examiner	Art Unit	
				Nyemah Grazier	1626	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
Class	Subclass	Date	Examiner		DATE	EXMR
548	533	2/28/2007	NG	STN structure search	2/28/2007	NG
514	423	2/28/2007	NG			
				IDS	2/28/2007	NG
				Inventor Name Search	2/28/2007	NG
<i>search has been updated 8/1/07 R.S.</i>				<i>search has been updated (ESR) 8/1/07 R.S.</i>		
INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
574	423	8/30/07	R.S.			
548	533	8/30/07	R.S.			